



---

## P-Channel 20-V (D-S) MOSFET with Copper Leadframe

---

### Characteristics

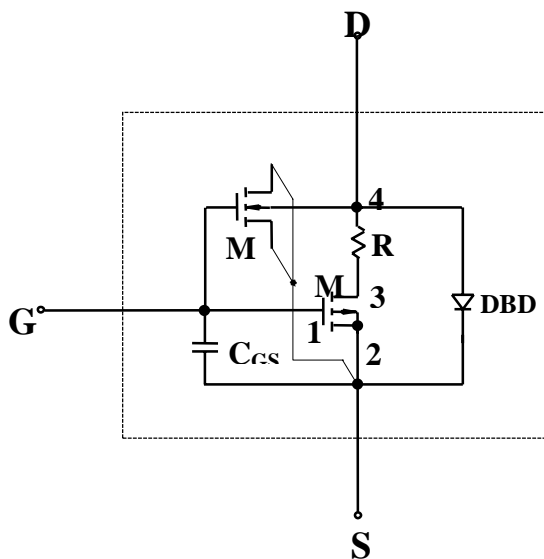
- P-channel Vertical DMOS
- Macro-Model (Sub-circuit)
- Level 3 MOS
- Applicable for Both Linear and Switch Mode
- Applicable Over a -55 to 125°C Temperature Range
- Models Gate Charge, Transient, and Diode Reverse Recovery Characteristics

### Description

The attached SPICE Model describes typical electrical characteristics of the p-channel vertical DMOS. The sub-circuit model was extracted and optimized over a -55°C to 125°C temperature range under pulse conditions for 0 to -5 volts gate drives. Saturated output impedance model accuracy has been maximized for gate biases near threshold voltage. A novel gate-to-drain

feedback capacitor network is used to model gate charge characteristics while avoiding convergence problems of switched  $C_{gd}$  model. Model parameter values are optimized to provide a best fit to measure electrical data and are not intended as an exact physical description of a device.

### Model Sub-circuit



This document is intended as a SPICE modeling guideline and does not constitute a commercial product data sheet. Designers should refer to the appropriate data sheet of the same number for guaranteed specification limits.



## SPICE Device Model Si1413EDH

Model Evaluation

P-Channel Device ( $T_J=25^{\circ}\text{C}$  Unless Otherwise Noted)

Parameter	Symbol	Test Conditions	Simulated Data	Measured Data	Unit
<b>Static</b>					
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -100\mu\text{A}$	<b>0.80</b>		V
On-State Drain Current <sup>a</sup>	$I_{D(on)}$	$V_{DS} = -5\text{V}, V_{GS} = -4.5\text{V}$	<b>36</b>		A
Drain-Source On-State Resistance <sup>a</sup>	$r_{DS(on)}$	$V_{GS} = -4.5\text{V}, I_D = -2.9\text{A}$ $V_{GS} = -2.5\text{V}, I_D = -2.4\text{A}$ $V_{GS} = -1.8\text{V}, I_D = -1.0\text{A}$	<b>0.098</b> <b>0.132</b> <b>0.178</b>	0.095 0.125 0.180	$\Omega$
Forward Transconductance <sup>a</sup>	$g_{fs}$	$V_{DS} = -10\text{V}, I_D = -2.9\text{A}$	<b>6.7</b>	6	S
Diode Forward Voltage <sup>a</sup>	$V_{SD}$	$I_S = -1.4\text{A}, V_{GS} = 0\text{V}$	<b>- 0.80</b>	- 0.80	V
<b>Dynamic <sup>b</sup></b>					
Total Gate Charge	$Q_g$	$V_{DS} = -10\text{V},$ $V_{GS} = -4.5\text{V}, I_D = -2.9\text{A}$	<b>5.6</b>	5.6	nC
Gate-Source Charge	$Q_{gs}$		<b>1.2</b>	1.2	
Gate-Drain Charge	$Q_{gd}$		<b>1.2</b>	1.2	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -10\text{V}, R_L = 10\Omega$ $I_D \cong -1\text{A}, V_{GEN} = -4.5\text{V},$ $R_G = 6\Omega$	<b>1.1</b>	0.75	ns
Rise Time	$t_r$		<b>2.9</b>	1.6	
Turn-Off Delay Time	$t_{d(off)}$		<b>9.3</b>	3.9	
Fall Time	$t_f$		<b>15</b>	3.9	

Notes:

a) Pulse test; pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$

b) Guaranteed by design, not subject to production testing



## SPICE Device Model Si1413EDH

Comparison of Model with Measured Data  
( $T_J=25^\circ\text{C}$  Unless Otherwise Noted)

